

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/601,704	KONDO, TAKAYUKI	
Examiner		Art Unit		Page 1 of 2
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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	I	US-			
	J	US-	.		
	K	US-			
	L	US-			
	M	US-			

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